

IGBT

TRENCHSTOP™ IGBT4 High Power Chip  
IGC99T120T8RH

Data Sheet

Industrial Power Control



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## TRENCHSTOP™ IGBT4 High Power Chip

### Features:

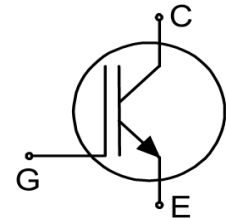
- 1200V trench & field stop technology
- LOW  $V_{CEsat}$
- Soft turn off
- Positive temperature coefficient
- Easy paralleling

### Recommended for:

- Medium / high power modules

### Applications:

- Medium / high power drives



Chip Type	$V_{CE}$	$I_{Cn}$	Die Size	Package
IGC99T120T8RH	1200V	100A	9.5mm x 10.39mm	Sawn on foil

### Mechanical Parameters

Die size	9.5 x 10.39	mm <sup>2</sup>
Emitter pad size	See chip drawing	
Gate pad size	1.31 x 0.811	
Area total	98.71	
Silicon thickness	140	μm
Wafer size	200	mm
Maximum possible chips per wafer	258	
Passivation frontside	Photoimide	
Pad metal	3200nm AlSiCu	
Backside metal	Ni Ag – system To achieve a reliable solder connection it is strongly recommended not to consume the Ni layer completely during production process	
Die bond	Electrically conductive epoxy glue and soft solder	
Wire bond	Al, ≤500μm	
Reject ink dot size	∅ 0.65mm; max. 1.2mm	
Storage environment (<6 months)	for original and sealed MBB bags	Ambient atmosphere air, temperature 17°C – 25°C
	for open MBB bags	Acc. IEC 62258-3; Section 9.4 Storage Environment.

## Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-emitter voltage, $T_{vj}=25^{\circ}\text{C}$	$V_{CE}$	1200	V
DC collector current, limited by $T_{vj\text{ max}}^1$	$I_C$	-	A
Pulsed collector current, $t_p$ limited by $T_{vj\text{ max}}^2$	$I_{C,puls}$	300	A
Gate-emitter voltage	$V_{GE}$	$\pm 20$	V
Virtual junction operating temperature	$T_{vj}$	-40 ... +175	$^{\circ}\text{C}$
Short circuit data <sup>1/2/3</sup> $V_{GE}=15\text{V}$ , $V_{CC}=800\text{V}$ , $T_{vj}=150^{\circ}\text{C}$	$t_{sc}$	10	$\mu\text{s}$

## Static Characteristics (tested on wafer), $T_{vj}=25^{\circ}\text{C}$

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Collector-emitter breakdown voltage	$V_{(BR)CES}$	$V_{GE}=0\text{V}$ , $I_C=3.8\text{mA}$	1200	-	-	V
Collector-emitter saturation voltage	$V_{CEsat}$	$V_{GE}=15\text{V}$ , $I_C=100\text{A}$	1.48	1.70	1.92	
Gate-emitter threshold voltage	$V_{GE(th)}$	$I_C=3.8\text{mA}$ , $V_{GE}=V_{CE}$	5.1	5.8	6.4	
Zero gate voltage collector current	$I_{CES}$	$V_{CE}=1200\text{V}$ , $V_{GE}=0\text{V}$	-	-	13	$\mu\text{A}$
Gate-emitter leakage current	$I_{GES}$	$V_{CE}=0\text{V}$ , $V_{GE}=20\text{V}$	-	-	120	nA
Integrated gate resistor	$r_G$		-	7.5	-	$\Omega$

## Electrical Characteristics <sup>2</sup>

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Collector-emitter saturation voltage	$V_{CEsat}$	$V_{GE}=15\text{V}$ , $I_C=100\text{A}$ , $T_{vj}=150^{\circ}\text{C}$	-	2.1	-	V
Input capacitance	$C_{ies}$	$V_{CE}=25\text{V}$ , $V_{GE}=0\text{V}$ , $f=1\text{MHz}$	-	6300	-	pF
Reverse transfer capacitance	$C_{res}$	$T_{vj}=25^{\circ}\text{C}$	-	270	-	

<sup>1</sup> Depending on thermal properties of assembly.

<sup>2</sup> Not subject to production test - verified by design/characterization.

<sup>3</sup> Allowed number of short circuits: <1000; time between short circuits: >1s.



# IGC99T120T8RH

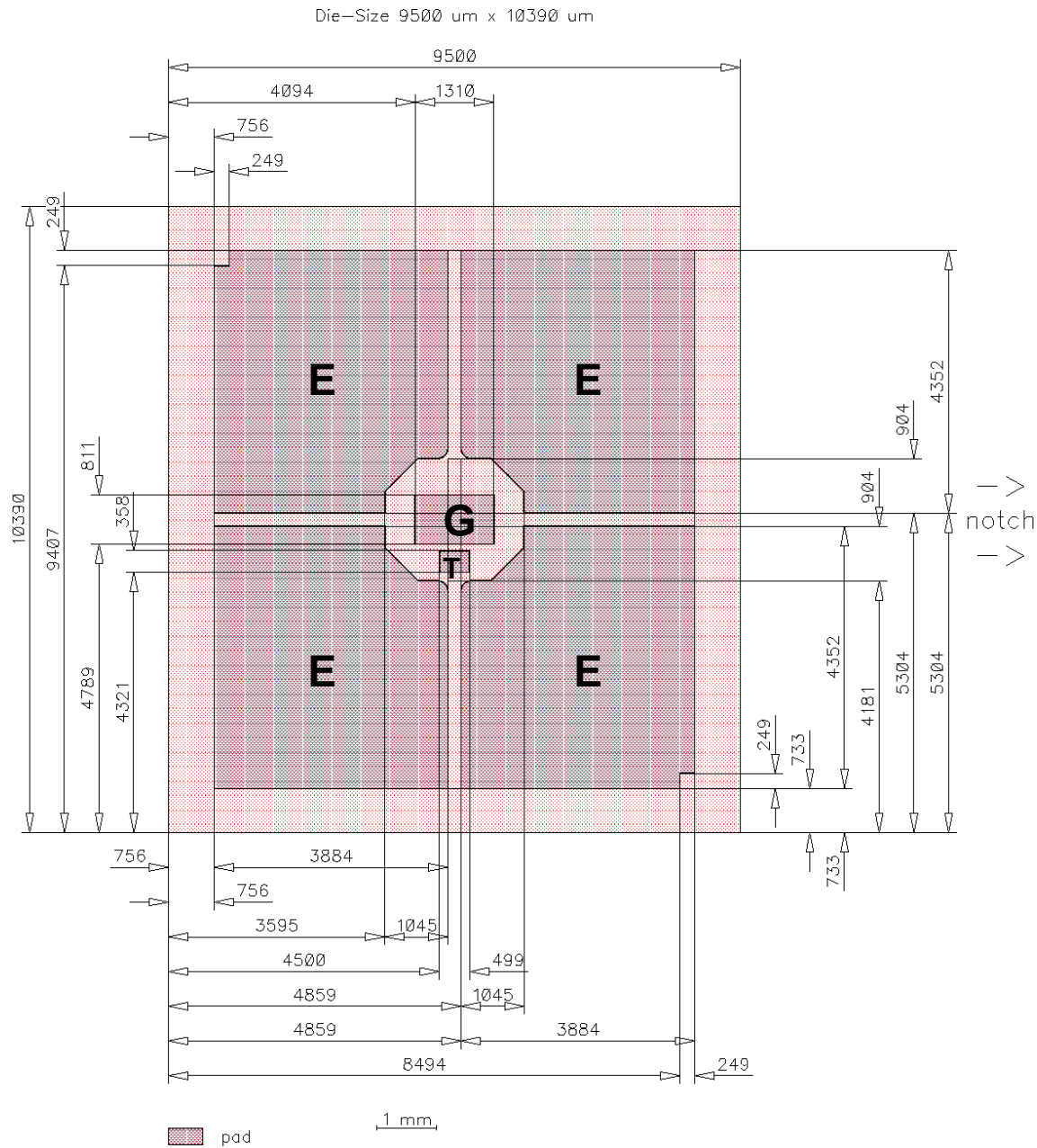
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## Further Electrical Characteristics

Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.

Application example	FZ400R12KP4	Rev. 2.2
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## Chip Drawing



**E** = Emitter  
**G** = Gate  
**T** = Test pad do not contact



# IGC99T120T8RH

## Bare Die Product Specifics

Test coverage at wafer level cannot cover all application conditions. Therefore it is recommended to test all characteristics which are relevant for the application at package level, including RBSOA and SCSOA.

## Description

AQL 0.65 for visual inspection according to failure catalogue

Electrostatic Discharge Sensitive Device according to MIL-STD 883

## Revision History

Revision	Subjects (major changes since last revision)	Date
2.0	Final data sheet	29.04.2016

## Relevant Application Notes

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